

Notice of References Cited	Application/Control No. 10/799,216	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Rodney Amadiz	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0117190	06-2005	Iwauchi et al.	359/237
*	B	US-6,069,676	05-2000	Yuyama, Harumi	349/62
*	C	US-7,002,546	02-2006	Stuppi et al.	345/102
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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